

Low profile silicon NPN RF bipolar transistor









Product description

The BFR340L3 is a low noise device based on Si that is part of Infineon's established third generation RF bipolar transistor family. Its transition frequency $f_{\rm T}$ of 14 GHz, low current and low voltage characteristics make the device suitable for low current amplifiers. It remains cost competitive without compromising on ease of use.



Feature list

- Minimum noise figure NF_{min} = 1.15 dB at 1.8 GHz, 3 V, 1 mA
- High gain G_{ms} = 17.5 dB at 1.8 GHz, 3 V, 5 mA
- OIP₃ = 12.5 dBm at 1.8 GHz, 3 V, 5 mA

Product validation

Qualified for industrial applications according to the relevant tests of JEDEC47/20/22.

Potential applications

- Low noise amplifiers (LNAs) for FM and AM radio
- LNAs for sub-1 GHz ISM band applications

Device information

Table 1 Part information

Product name / Ordering code	Package	Pin con	figurati	on	Marking	Pieces / Reel
BFR340L3 / BFR340L3E6327XTMA1	TSLP-3-1	1 = B	2 = E	3 = C	FA	15000

Attention: ESD (Electrostatic discharge) sensitive device, observe handling precautions

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Absolute maximum ratings

1 Absolute maximum ratings

Table 2 Absolute maximum ratings at $T_A = 25$ °C (unless otherwise specified)

Parameter	Symbol	Va	lues	Unit	Note or test condition	
		Min.	Max.			
Collector emitter voltage	V_{CEO}	_	6	V	Open base	
Collector emitter voltage	V_{CES}		15		E-B short circuited	
Collector base voltage	V_{CBO}		15		Open emitter	
Emitter base voltage	V_{EBO}		2		Open collector	
Base current	I _B		2	mA	-	
Collector current	I _C		10			
Total power dissipation 1)	P _{tot}	1	60	mW	<i>T</i> _S ≤ 120 °C	
Junction temperature	TJ	1	150	°C	-	
Storage temperature	T_{Stg}	-55				

Attention: Stresses above the max. values listed here may cause permanent damage to the device.

Exposure to absolute maximum rating conditions for extended periods may affect device reliability. Exceeding only one of these values may cause irreversible damage to the integrated circuit.

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 2019-01-25
 2019-01-25

 T_S is the soldering point temperature. T_S is measured on the emitter lead at the soldering point of the PCB.



Thermal characteristics

2 Thermal characteristics

Table 3 Thermal resistance

Parameter	Symbol	Values			Values Uni		Unit	Note or test condition
		Min.	Тур.	Max.				
Junction - soldering point	R _{thJS}	_	500	_	K/W	-		

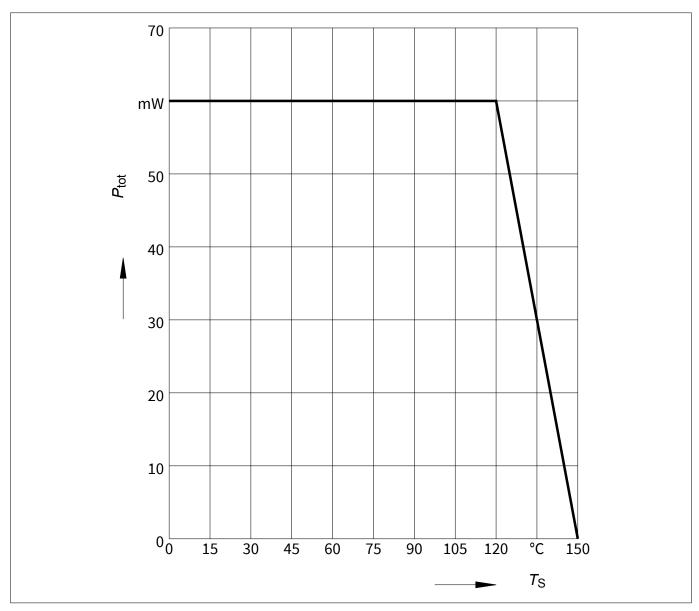


Figure 1 Total power dissipation $P_{\text{tot}} = f(T_S)$

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Electrical characteristics

3 Electrical characteristics

3.1 DC characteristics

Table 4 DC characteristics at $T_A = 25$ °C (unless otherwise specified)

Parameter	Symbol		Values			Note or test condition	
		Min.	Тур.	Max.			
Collector emitter breakdown voltage	V _{(BR)CEO}	6	9	-	V	$I_C = 1 \text{ mA}, I_B = 0,$ open base	
Collector emitter leakage current	I _{CES}	_	_	10 ²⁾	μΑ	$V_{CE} = 15 \text{ V}, V_{BE} = 0,$ E-B short circuited	
Collector base leakage current	I _{CBO}			100 ²⁾	nA	$V_{CB} = 5 \text{ V}, I_E = 0,$ open emitter	
Emitter base leakage current	I _{EBO}			1 ²⁾	μΑ	$V_{\text{EB}} = 1 \text{ V}, I_{\text{C}} = 0,$ open collector	
DC current gain	h _{FE}	90	120	160		$V_{CE} = 3 \text{ V}, I_{C} = 5 \text{ mA},$ pulse measured	

3.2 General AC characteristics

Table 5 General AC characteristics at $T_A = 25$ °C

Parameter	Symbol		Values			Note or test condition	
		Min.	Тур.	Max.			
Transition frequency	f_{T}	10	14	_	GHz	$V_{CE} = 3 \text{ V}, I_{C} = 6 \text{ mA},$ f = 1 GHz	
Collector base capacitance	C_{CB}	_	0.17	0.4	pF	$V_{CB} = 5 \text{ V}, V_{BE} = 0,$ f = 1 MHz, emitter grounded	
Collector emitter capacitance	C _{CE}		0.13	-		$V_{CE} = 5 \text{ V}, V_{BE} = 0,$ f = 1 MHz, base grounded	
Emitter base capacitance	C _{EB}		0.12			$V_{\rm EB}$ = 0.5 V, $V_{\rm CB}$ = 0, f = 1 MHz, collector grounded	

² Maximum values not limited by the device but by the short cycle time of the 100% test.



Electrical characteristics

3.3 Frequency dependent AC characteristics

Measurement setup is a test fixture with Bias-T's in a 50 Ω system, T_A = 25 °C.

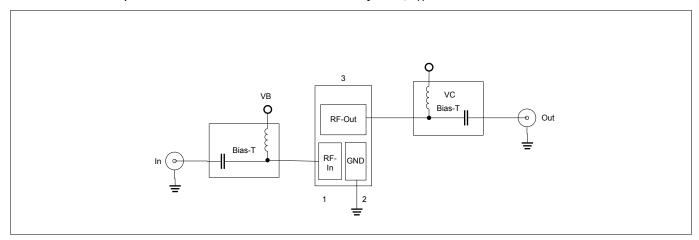


Figure 2 Testing circuit

Table 6 AC characteristics, $V_{CE} = 3 \text{ V}, f = 1.8 \text{ GHz}$

Parameter	Symbol		Values			Note or test condition
		Min.	Тур.	Max.		
Power gain		_		_	dB	
Maximum power gain	G _{ms}		17.5			$I_{\rm C}$ = 5 mA
Transducer gain	$ S_{21} ^2$		14			
Noise figure						
Minimum noise figure	<i>NF</i> _{min}		1.15			$I_{\rm C} = 1 \text{mA}$
Linearity					dBm	
3rd order intercept point at output	OIP ₃		12.5			$I_{\rm C} = 5 \text{ mA}, Z_{\rm S} = Z_{\rm L} = 50 \Omega$
• 1 dB gain compression point at output	OP_{1dB}		-1			

Table 7 AC characteristics, $V_{CE} = 3 \text{ V}$, f = 3 GHz

Parameter	Symbol	Values			Unit	Note or test condition
		Min.	Тур.	Max.		
Power gain		_		_	dB	
 Maximum power gain 	G _{ma}		13			$I_{\rm C} = 5 \text{mA}$
 Transducer gain 	$ S_{21} ^2$		10			

Note:

 $G_{\rm ms}$ = $IS_{21}/S_{12}I$ for k < 1; $G_{\rm ma}$ = $IS_{21}/S_{12}I$ (k-(k^2 -1) $^{1/2}$) for k > 1. In order to get the NF_{min} values stated in this chapter, the test fixture losses have been subtracted from all measured results. OIP₃ value depends on termination of all intermodulation frequency components. Termination used for this measurement is 50 Ω from 0.1 MHz to 6 GHz.



Package information TSLP-3-1

4 Package information TSLP-3-1

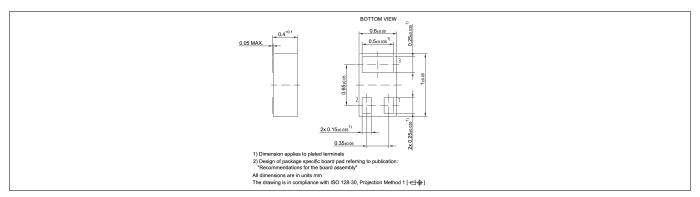


Figure 3 Package outline

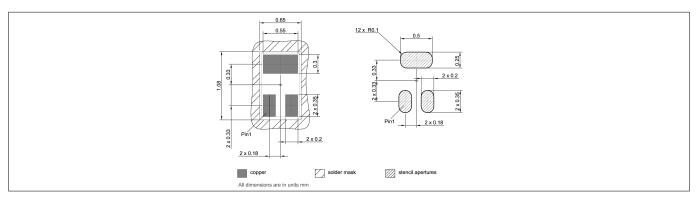


Figure 4 Foot print

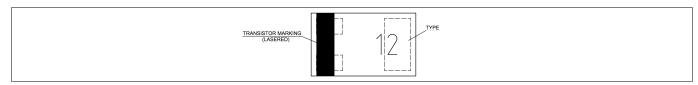


Figure 5 Marking layout example

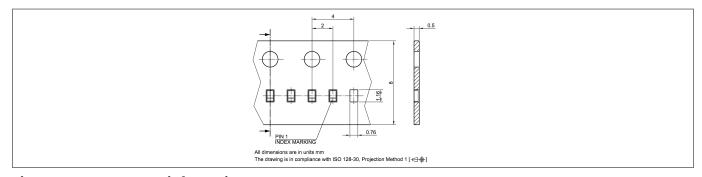


Figure 6 Tape information

Note: See our Recommendations for Printed Circuit Board Assembly of TSLP/TSSLP/TSNP Packages.

The marking layout is an example. For the real marking code refer to the device information on the first page. The number of characters shown in the layout example is not necessarily the real one. The marking layout can consist of less characters.

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Revision history

Revision history

Document version	Date of release	Description of changes
Revision 2.0	2019-01-25	New datasheet layout.

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 ${\bf Email: erratum@infineon.com}$

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